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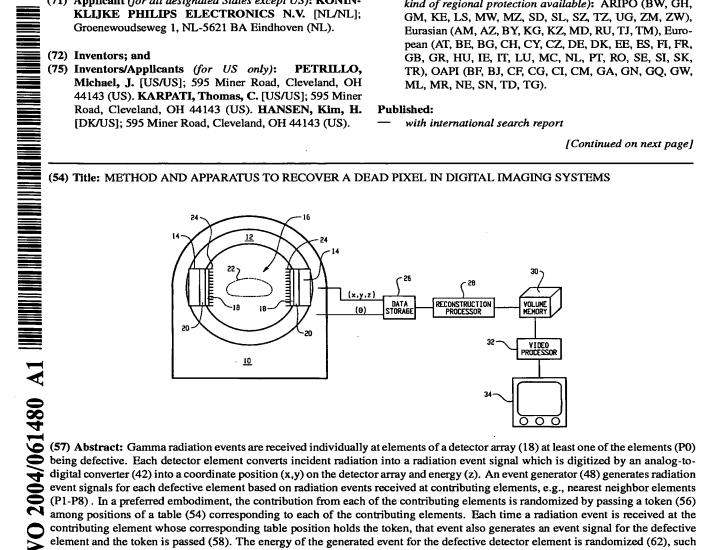
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contributing element whose corresponding table position holds the token, that event also generates an event signal for the defective element and the token is passed (58). The energy of the generated event for the defective detector element is randomized (62), such as by replacing the least significant bits with random numbers.



For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.